MOSFET - Power, Single N-Channel, TOLL

80 V, 2 mΩ, 238 A

NTBLS002N08MC

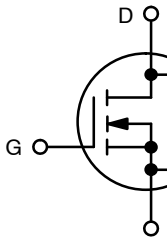
$V_{(BR)DSS}$	$R_{DS(ON)}$ MAX	I_D MAX
80 V	2 mΩ @ 10 V	238 A
	5 mΩ @ 6 V	

Features

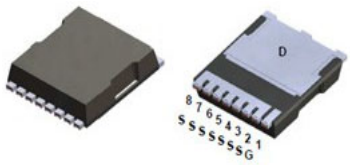
- Low $R_{DS(on)}$ to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- Lowers Switching Noise/EMI
- These Devices are Pb−Free, Halogen Free/BFR Free and are RoHS Compliant

Typical Applications

- Power Tools, Battery Operated Vacuums
- UAV/Drones, Material Handling
- BMS/Storage, Home Automation

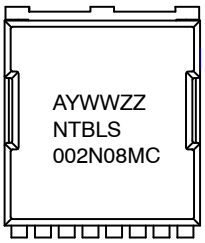


N−CHANNEL MOSFET



M0−299A
TOLL
CASE 100CU

MARKING DIAGRAM



NTBLS002N08MC = Specific Device Code
A = Assembly Location
Y = Year
WW = Work Week
ZZ = Lot Traceability

ORDERING INFORMATION

See detailed ordering, marking and shipping information on page 5 of this data sheet.

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain−to−Source Voltage			V_{DSS}	80	V
Gate−to−Source Voltage			V_{GS}	±20	V
Continuous Drain Current $R_{\theta JC}$ (Note 2)	Steady State	T_C = 25°C	I_D	238	A
Power Dissipation $R_{\theta JC}$ (Note 2)			P_D	208	W
Continuous Drain Current $R_{\theta JA}$ (Notes 1, 2)	Steady State	T_A = 25°C	I_D	28	A
Power Dissipation $R_{\theta JA}$ (Notes 1, 2)			P_D	2.9	W
Pulsed Drain Current	T_C = 25°C, t_p = 10 μs		I_{DM}	3523	A
Operating Junction and Storage Temperature Range			T_J, T_{stg}	−55 to +150	°C
Single Pulse Drain−to−Source Avalanche Energy ($I_{L(pk)}$ = 28 A, L = 3 mH)			E_{AS}	1176	mJ
Lead Temperature for Soldering Purposes (1/8″ from case for 10 s)			T_L	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction−to−Case − Steady State (Note 2)	$R_{\theta JC}$	0.6	°C/W
Junction−to−Ambient − Steady State (Note 2)	$R_{\theta JA}$	43	

1. Surface−mounted on FR4 board using a 1 in^2 pad size, 1 oz. Cu pad.
2. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

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ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Typ	Max	Unit
OFF CHARACTERISTICS							
Drain−to−Source Breakdown Voltage	$V_{(BR)DSS}$	V_{GS} = 0 V, I_D = 250 μA		80			V
Drain−to−Source Breakdown Voltage Temperature Coefficient	$V_{(BR)DSS}/T_J$	I_D = 250 μA, ref to 25°C			64		mV/°C
Zero Gate Voltage Drain Current	I_{DSS}	V_{GS} = 0 V, V_{DS} = 80 V	T_J = 25°C			1	μA
			T_J = 125°C			100	
Gate−to−Source Leakage Current	I_{GSS}	V_{DS} = 0 V, V_{GS} = ±20 V				±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	$V_{GS(TH)}$	V_{GS} = V_{DS}, I_D = 530 μA		2.0	3.0	4.0	V
Negative Threshold Temperature Coefficient	$V_{GS(TH)}/T_J$	I_D = 530 μA, ref to 25°C			−8.5		mV/°C
Drain−to−Source On Resistance	$R_{DS(on)}$	V_{GS} = 10 V	I_D = 80 A		1.7	2.0	mΩ
Drain−to−Source On Resistance	$R_{DS(on)}$	V_{GS} = 6 V	I_D = 47 A		2.8	5.0	mΩ
Forward Transconductance	g_{FS}	V_{DS} = 5 V, I_D = 80 A			186		S
Gate Resistance	R_G	T_A = 25°C			0.4		Ω
CHARGES, CAPACITANCES & GATE RESISTANCE							
Input Capacitance	C_{ISS}	V_{GS} = 0 V, f = 1 MHz, V_{DS} = 40 V			6580		pF
Output Capacitance	C_{OSS}				1950		
Reverse Transfer Capacitance	C_{RSS}				74		
Total Gate Charge	$Q_{G(TOT)}$	V_{GS} = 10 V, V_{DS} = 40 V; I_D = 80 A			92		nC
Threshold Gate Charge	$Q_{G(TH)}$				19		
Gate−to−Source Charge	Q_{GS}				30		
Gate−to−Drain Charge	Q_{GD}				21		
Output Charge	Q_{OSS}				123		
Sync Charge	Q_{sync}				81		
Plateau Voltage	$V_{plateau}$				5		V
SWITCHING CHARACTERISTICS, V_{GS} = 10 V (Note 3)							
Turn−On Delay Time	$t_{d(ON)}$	V_{GS} = 10 V, V_{DS} = 40 V, I_D = 80 A, R_G = 6 Ω			34		ns
Rise Time	t_r				30		
Turn−Off Delay Time	$t_{d(OFF)}$				62		
Fall Time	t_f				24		
DRAIN−SOURCE DIODE CHARACTERISTICS							
Forward Diode Voltage	V_{SD}	V_{GS} = 0 V, I_S = 2 A			0.7	1.2	V
		V_{GS} = 0 V, I_S = 80 A			0.8	1.3	
Reverse Recovery Time	t_{RR}	I_F = 40 A, di/dt = 300 A/μs			35		nS
Reverse Recovery Charge	Q_{RR}				74		nC
Reverse Recovery Time	t_{RR}	I_F = 40 A, di/dt = 1000 A/μs			27		nS
Reverse Recovery Charge	Q_{RR}				166		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Switching characteristics are independent of operating junction temperatures.

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TYPICAL CHARACTERISTICS

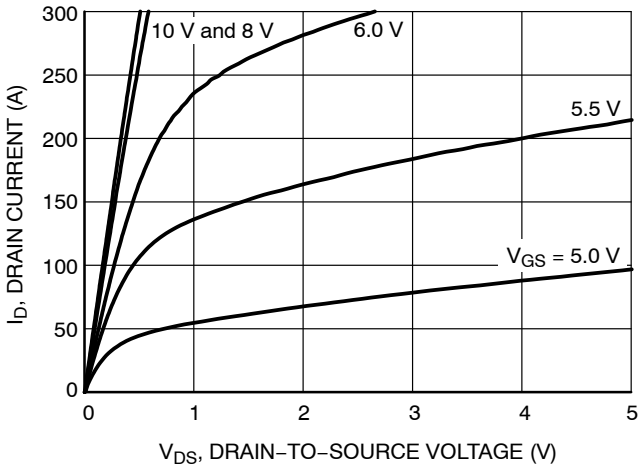

Figure 1. On−Region Characteristics

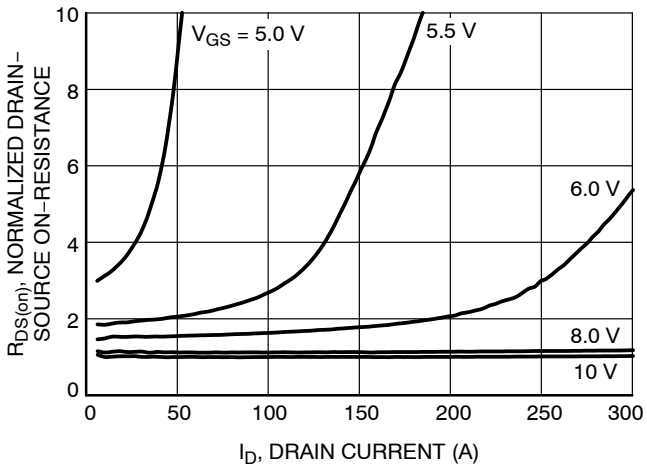

Figure 2. $R_{DS(on)}$ Normalized vs. I_D

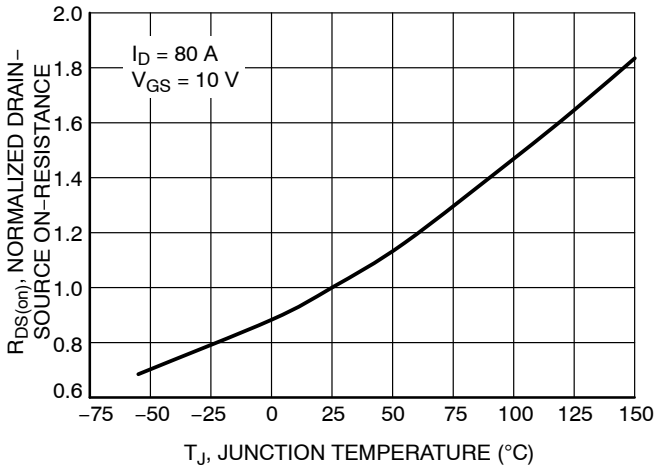

Figure 3. $R_{DS(on)}$ vs. Junction Temperature

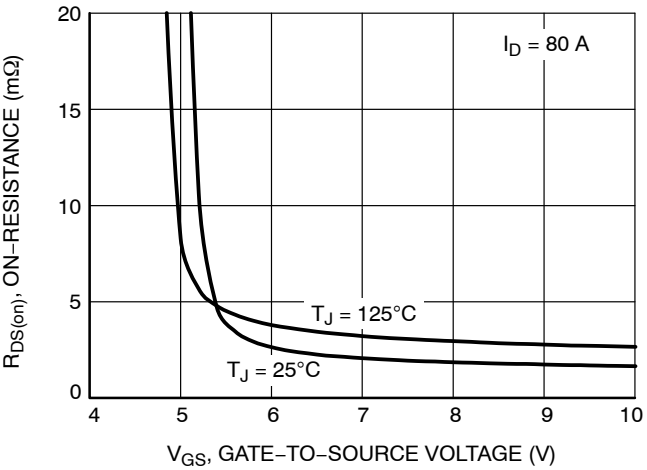

Figure 4. On−Resistance vs. Gate−to−Source Voltage

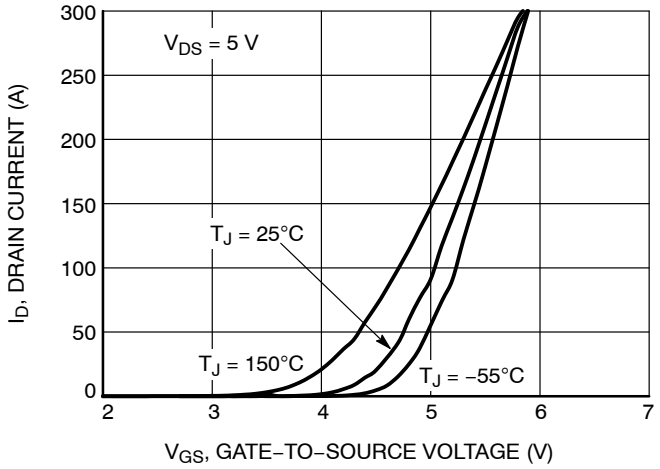

Figure 5. Drain Current vs. Gate−to−Source Voltage

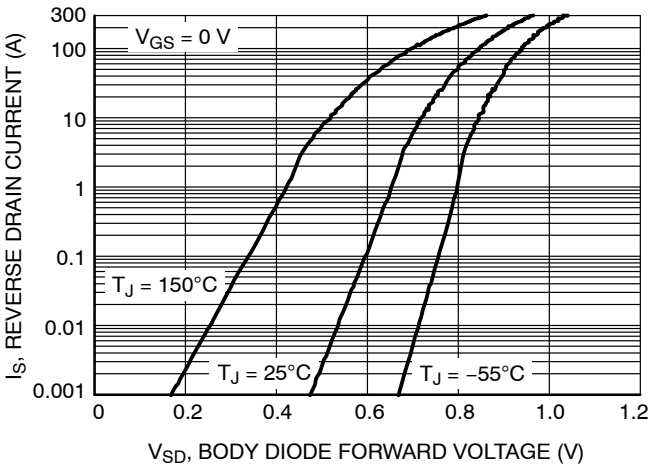

Figure 6. Reverse Drain Current vs. Body Diode Forward Voltage

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TYPICAL CHARACTERISTICS

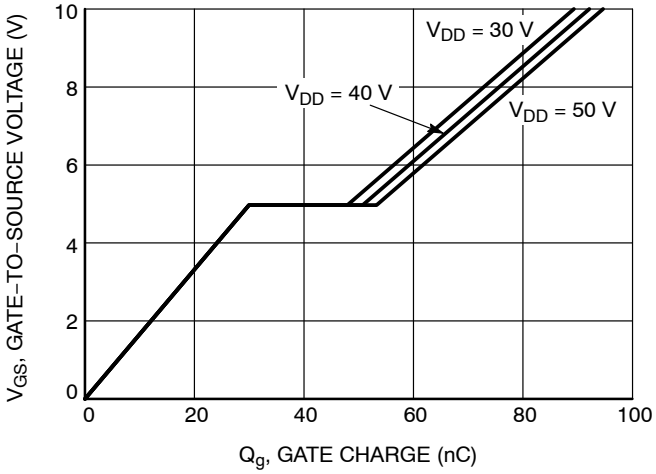

Figure 7. Gate Charge

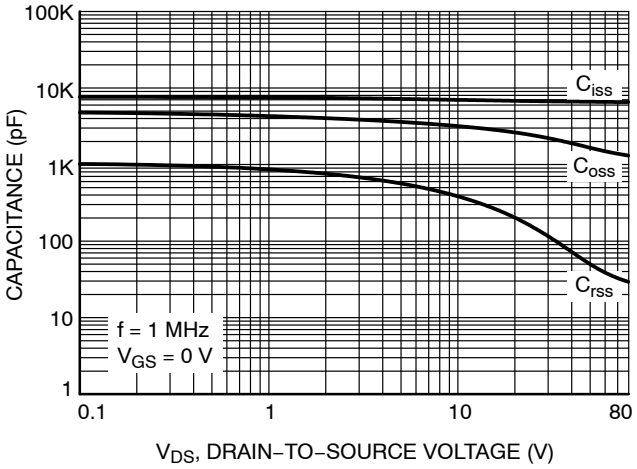

Figure 8. Capacitance Variation

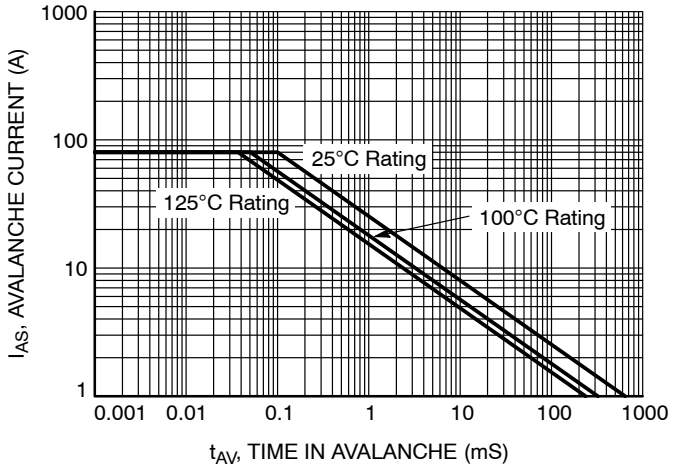

Figure 9. UIL

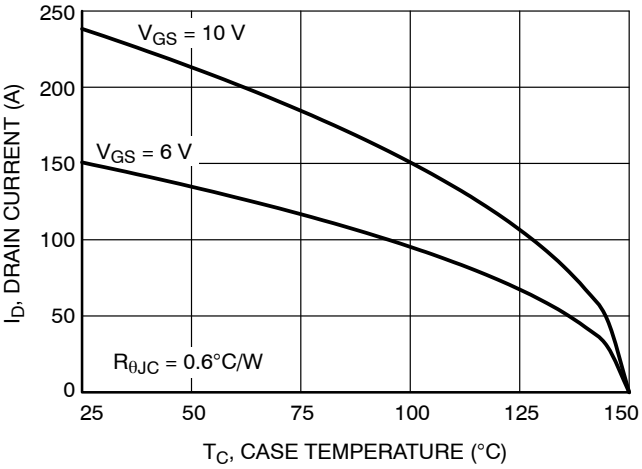

Figure 10. Drain Current vs. Case Temperature

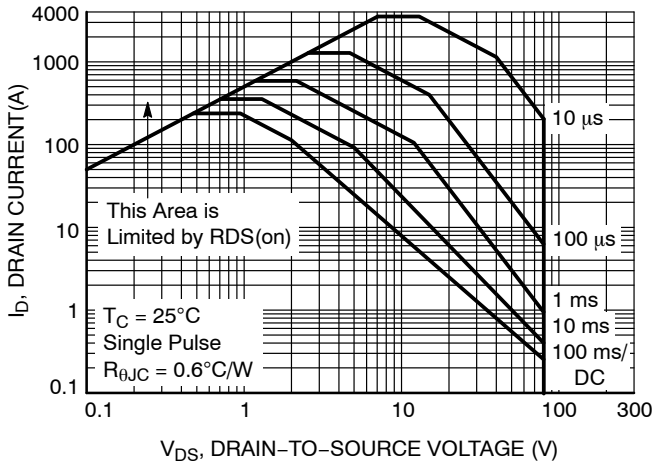

Figure 11. Maximum Rated Forward Biased Safe Operating Area

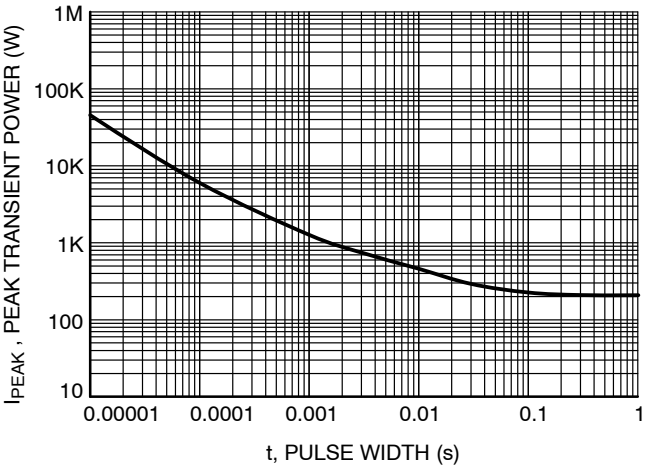

Figure 12. Peak Power

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TYPICAL CHARACTERISTICS

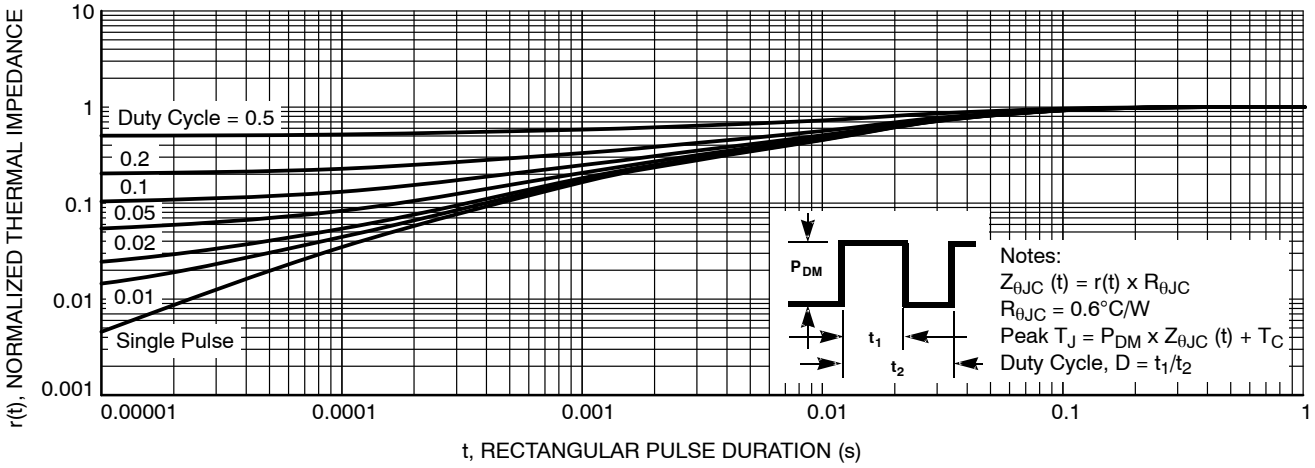

Figure 13. Transient Thermal Impedance

DEVICE ORDERING INFORMATION

Device	Marking	Package	Shipping†
NTBLS002N08MC	NTBLS 002N08MC	M0−299A (Pb−Free)	2000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

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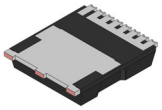
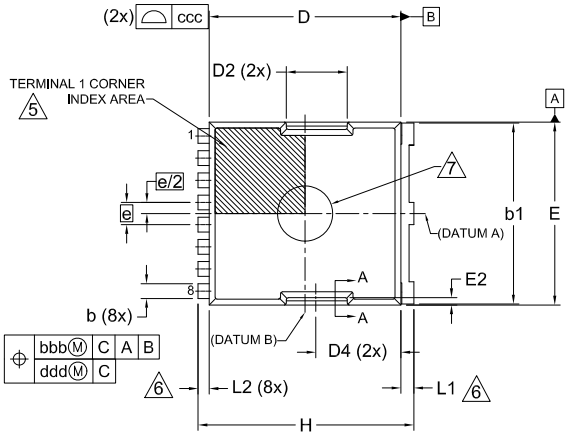
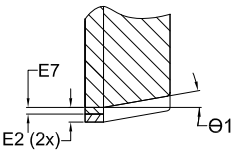


H−PSOF8L 11.68x9.80x2.30, 1.20P
CASE 100CU
ISSUE F

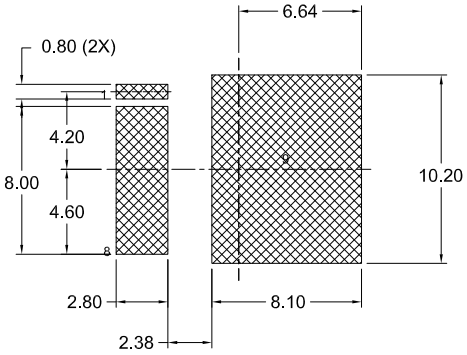
DATE 30 JUL 2024



TOP VIEW

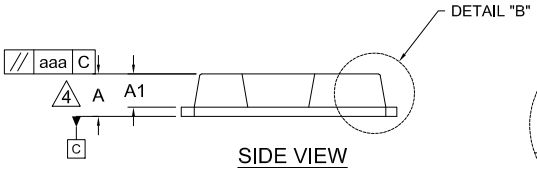


SECTION "A-A"
SCALE: 2X

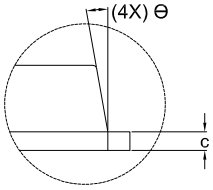


LAND PATTERN RECOMMENDATION

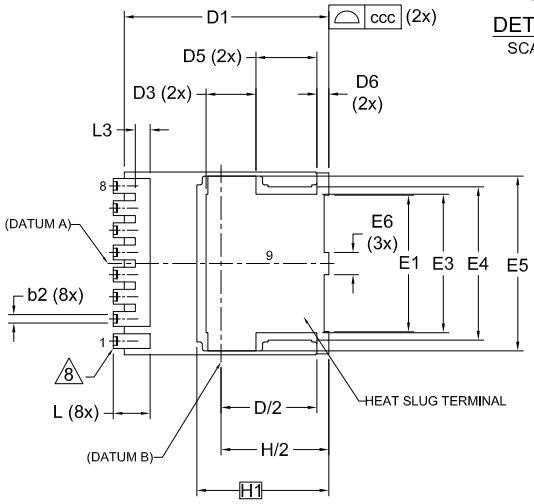
*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ONSEMI SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.



SIDE VIEW



DETAIL "B"
SCALE: 2X



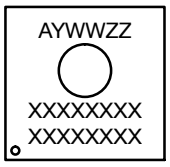
BOTTOM VIEW

NOTES:
1. PACKAGE STANDARD REFERENCE: JEDEC MO-299, ISSUE B.
2. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2018.
3. "e" REPRESENTS THE TERMINAL PITCH.
4. THIS DIMENSION INCLUDES ENCAPSULATION THICKNESS "A1", AND PACKAGE BODY THICKNESS, BUT DOES NOT INCLUDE ATTACHED FEATURES, e.g.,EXTERNAL OR CHIP CAPACITORS. AN INTEGRAL HEATSLUG IS NOT CONSIDERED AS ATTACHED FEATURE.
5. A VISUAL INDEX FEATURE MUST BE LOCATED WITHIN THE HATCHED AREA.
6. DIMENSIONS b1,L1,L2 APPLY TO PLATED TERMINALS.
7. THE LOCATION AND SIZE OF EJECTOR MARKS ARE OPTIONAL.
8. THE LOCATION AND NUMBER OF FUSED LEADS ARE OPTIONAL.

DIM	MILLIMETERS		
	MIN.	NOM.	MAX.
A	2.20	2.30	2.40
A1	1.70	1.80	1.90
b	0.70	0.80	0.90
b1	9.70	9.80	9.90
b2	0.35	0.45	0.55
c	0.40	0.50	0.60
D	10.28	10.38	10.48
D/2	5.09	5.19	5.29
D1	10.98	11.08	11.18
D2	3.20	3.30	3.40
D3	2.60	2.70	2.80
D4	4.45	4.55	4.65
D5	3.20	3.30	3.40
D6	0.55	0.65	0.75
E	9.80	9.90	10.00
E1	7.30	7.40	7.50
E2	0.30	0.40	0.50
E3	7.40	7.50	7.60
E4	8.20	8.30	8.40

DIM	MILLIMETERS		
	MIN.	NOM.	MAX.
E5	9.36	9.46	9.56
E6	1.10	1.20	1.30
E7	0.15	0.18	0.21
e	1.20 BSC		
e/2	0.60 BSC		
H	11.58	11.68	11.78
H/2	5.74	5.84	5.94
H1	7.15 BSC		
L	1.90	2.00	2.10
L1	0.60	0.70	0.80
L2	0.50	0.60	0.70
L3	0.70	0.80	0.90
Θ	10° REF		
Θ1	10° REF		
aaa	0.20		
bbb	0.25		
ccc	0.20		
ddd	0.20		
eee	0.10		

GENERIC MARKING DIAGRAM*



A = Assembly Location
Y = Year
WW = Work Week
ZZ = Assembly Lot Code
XXXX = Specific Device Code

*This information is generic. Please refer to device data sheet for actual part marking. Pb−Free indicator, “G” or microdot “▪”, may or may not be present. Some products may not follow the Generic Marking.

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DESCRIPTION:	**H−PSOF8L 11.68x9.80x2.30, 1.20P**	**PAGE 1 OF 1**

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